MOSFET – N-Channel, POWERTRENCH

150 V, 167 A, 5.9 m Ω

FDH055N15A

Description

This N-Channel MOSFET is produced using ON Semiconductor's advanced POWERTRENCH® process that has been tai-lored to minimize the on-state resistance while maintaining superior switching performance.

Features

- $R_{DS(on)} = 4.8 \text{ m}\Omega \text{ (Typ.)} @ V_{GS} = 10 \text{ V}, I_D = 120 \text{ A}$
- Fast Switching Speed
- Low Gate Charge
- High Performance Trench Technology for Extremely Low R_{DS(on)}
- High Power and Current Handling Capability
- This Device is Pb-Free and is RoHS Compliant

Applications

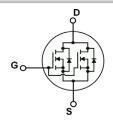
- Synchronous Rectification for ATX / Sever / Telecom PSU
- Battery Protection Circuit
- Motor Drives and Uninterruptible Power Supplies
- Micro Solar Inverter



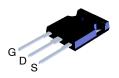
ON Semiconductor®

www.onsemi.com

V _{DS}	R _{DS(ON)} MAX	I _D MAX	
150 V	5.9 mΩ @ 10 V	167 A	



N-CHANNEL MOSFET



TO-247-3LD CASE 340CK

MARKING DIAGRAM



\$Y

= ON Semiconductor Logo

&Z &3 Assembly Plant CodeNumeric Date Code

&K

= Lot Code

FDH055N15A

= Specific Device Code

ORDERING INFORMATION

See detailed ordering and shipping information on page 2 of this data sheet.

ABSOLUTE MAXIMUM RATINGS ($T_C = 25$ °C unless otherwise noted)

Symbol		FDH055N15A	Unit	
V_{DSS}	Drain to Source Voltage		150	V
V_{GSS}	Gate to Source Voltage	- DC	±20	V
		– AC (f > 1 Hz)	±30	
I _D	Drain Current	- Continuous (T _C = 25°C, Silicon Limited)	167 (Note 1)	Α
		- Continuous (T _C = 100°C, Silicon Limited)	118	
		- Continuous (T _C = 25°C, Package Limited)	156	
I _{DM}	Drain Current	- Pulsed (Note 2)	668	Α
E _{AS}	Single Pulsed Avalanche Energy (Note 3)		835	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 4)		6.0	V/ns
P_{D}	Power Dissipation	(T _C = 25°C)	429	W
		– Derate above 25°C	2.86	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to + 175	°C
TL	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Second		300	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Calculated continuous current based on maximum allowable junction temperature, Package limitation current is 156 A.

- Calculated continuous current based on maximum anowable particular terms.
 Repetitive Rating: Pulse width limited by maximum junction temperature.
 Starting T_J = 25°C, L = 3 mH, I_{AS} = 23.6 A
 I_{SD} ≤ 120 A, di/dt ≤ 200 A/s, V_{DD} ≤ BV_{DSS}, Starting T_J = 25 °C.

THERMAL CHARACTERISTICS

Symbol	Parameter	FDH055N15A	Unit
$R_{ heta JC}$	Thermal Resistance, Junction to Case, Max.	0.35	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient, Max.	40	

PACKAGE MARKING AND ORDERING INFORMATION

Part Number	Top Mark	Package	Package Method	Reel Size	Tape Width	Quantity
FDH055N15A	FDH055N15A	TO-247-3LD	Tube	N/A	N/A	30 Units

ELECTRICAL CHARACTERISTICS ($T_C = 25$ °C unless otherwise noted)

Symbol	Parameter	Test Condition	Min.	Тур.	Max.	Unit
OFF CHARA	ACTERISTICS		•	-		
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	150	_	-	V
$\Delta BV_{DSS} / \Delta T_{J}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, Referenced to 25°C	-	0.1	-	V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 120 V, V _{GS} = 0 V	-	-	1	μΑ
		V _{DS} = 120 V, T _C = 150°C	-	-	500	
I _{GSS}	Gate to Body Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$	-	-	±100	nA
N CHARA	CTERISTICS					
V _{GS(th)}	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	2.0	_	4.0	V
R _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 10 V, I _D = 120 A	-	4.8	5.9	mΩ
9FS	Forward Transconductance	V _{DS} = 10 V, I _D = 120 A	_	219	-	S
YNAMIC C	HARACTERISTICS		•		•	
C _{iss}	Input Capacitance	V _{DS} = 75 V, V _{GS} = 0 V,	-	7100	9445	pF
C _{oss}	Output Capacitance	f = 1 MHz	-	664	885	pF
C _{rss}	Reverse Transfer Capacitance		_	23	35	pF
C _{oss(er)}	Energy Related Output Capacitance	V _{DS} = 75 V, V _{GS} = 0 V	-	1159	-	pF
Q _{g(tot)}	Total Gate Charge at 10 V	V _{DS} = 75 V, I _D = 120 A, V _{GS} = 10 V (Note 5)	-	92	-	nC
Q _{gs}	Gate to Source Gate Charge		-	31	-	nC
Q _{gs2}	Gate Charge Threshold to Plateau	(Note o)	-	15	-	nC
Q _{gd}	Gate to Drain "Miller" Charge		-	16	-	nC
ESR	Equivalent Series Resistance(G-S)	f = 1 MHz	-	1.2	-	Ω
WITCHING	CHARACTERISTICS					
t _{d(on)}	Turn-On Delay Time	$V_{DD} = 75 \text{ V}, I_D = 120 \text{ A},$		35	80	ns
t _r	Turn-On Rise Time	$V_{GS} = 10 \text{ V}, R_{G} = 4.7 \Omega$ (Note 5)	_	67	144	ns
t _{d(off)}	Turn-Off Delay Time	(Note 3)	_	71	152	ns
t _f	Turn-Off Fall Time	1	_	21	52	ns
RAIN-SOU	RCE DIODE CHARACTERISTICS				<u> </u>	
I _S	Maximum Continuous Drain to Source Diode Forward Current		-	_	167 (Note 1)	Α
I _{SM}	Maximum Pulsed Drain to Source Diode Forward Current		-	-	668	Α
V _{SD}	Drain to Source Diode Forward Voltage	V _{GS} = 0 V, I _{SD} = 120 A	-	-	1.25	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0 V, I _{SD} = 120 A, V _{DS} = 75 V,	-	105	-	ns
Q _{rr}	Reverse Recovery Charge	dI _F /dt = 100 A/μs	_	342	_	nC
Q _{rr}	Reverse Recovery Charge	$V_{GS} = 0 \text{ V}, I_{SD} = 30 \text{ A}, V_{DS} = 75 \text{ V},$ $dI_F/dt = 100 \text{ A}/\mu\text{s}$	-	348	-	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

5. Essentially Independent of Operating Temperature Typical Characteristics.

TYPICAL CHARACTERISTICS

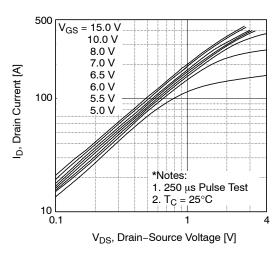


Figure 1. On-Region Characteristics

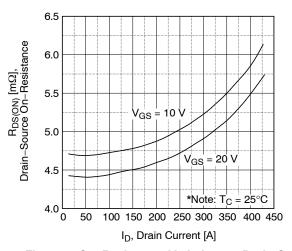


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

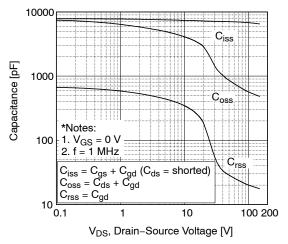


Figure 5. Capacitance Characteristics

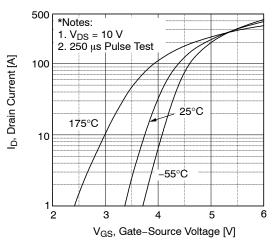


Figure 2. Transfer Characteristics

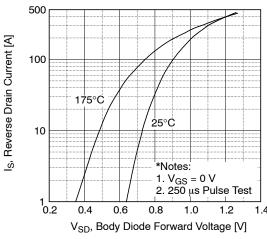


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

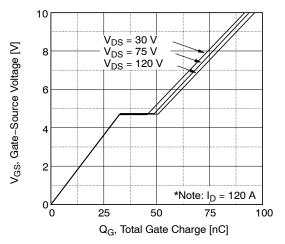


Figure 6. Gate Charge Characteristics

TYPICAL CHARACTERISTICS (continued)

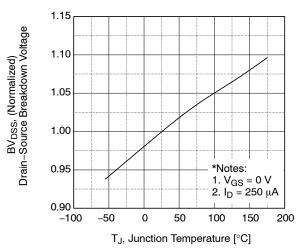


Figure 7. Breakdown Voltage Variation vs. Temperature

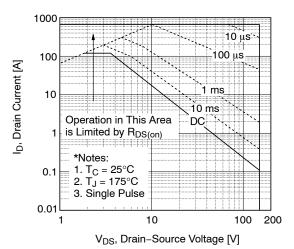


Figure 9. Maximum Safe Operating Area

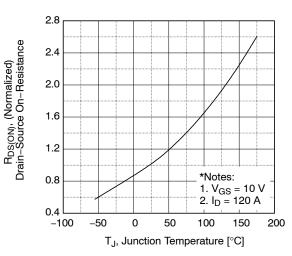


Figure 8. On–Resistance Variation vs. Temperature

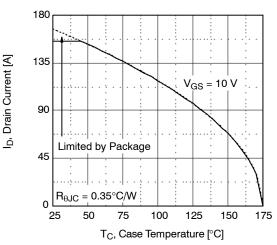


Figure 10. Maximum Drain Current vs. Case Temperature

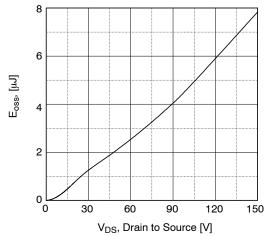


Figure 11. Eoss vs. Drain to Source Voltage

TYPICAL CHARACTERISTICS (continued)

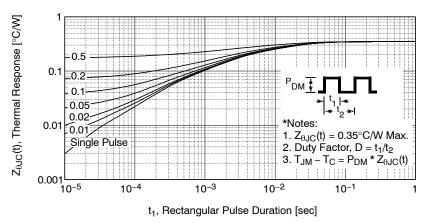


Figure 12. Transient Thermal Response Curve

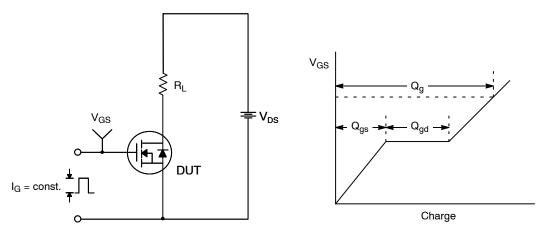


Figure 13. Gate Charge Test Circuit & Waveform

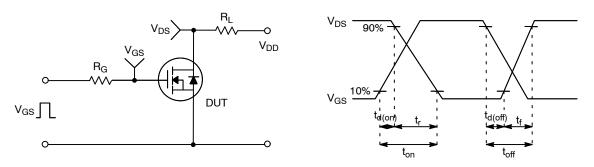


Figure 14. Resistive Switching Test Circuit & Waveforms

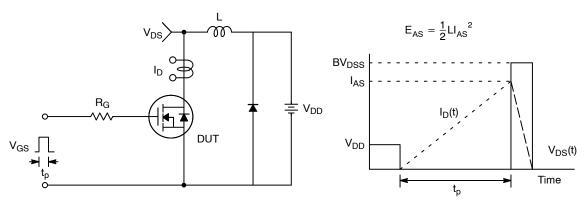


Figure 15. Unclamped Inductive Switching Test Circuit & Waveforms

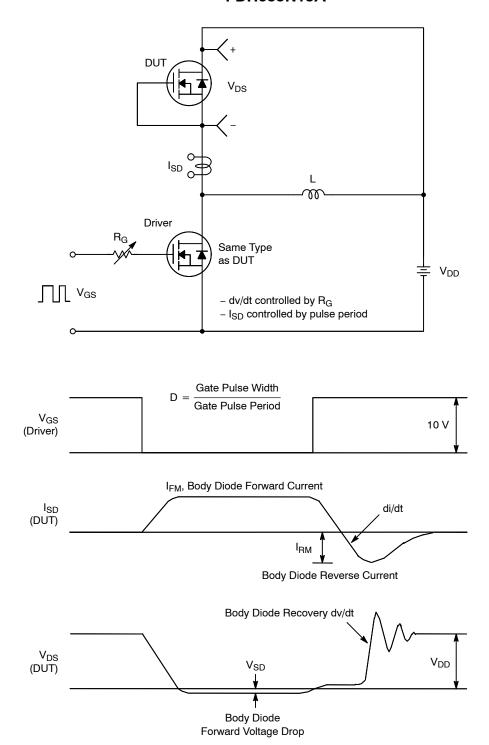
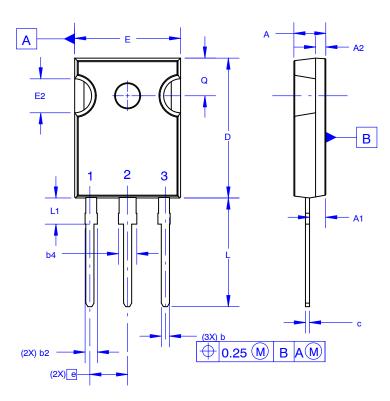


Figure 16. Peak Diode Recovery dv/dt Test Circuit & Waveforms

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TO-247-3LD SHORT LEAD

CASE 340CK ISSUE A





- A. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.
- B. ALL DIMENSIONS ARE IN MILLIMETERS.
- C. DRAWING CONFORMS TO ASME Y14.5 2009.
- D. DIMENSION A1 TO BE MEASURED IN THE REGION DEFINED BY L1.
- E. LEAD FINISH IS UNCONTROLLED IN THE REGION DEFINED BY L1.

GENERIC MARKING DIAGRAM*



XXXX = Specific Device Code

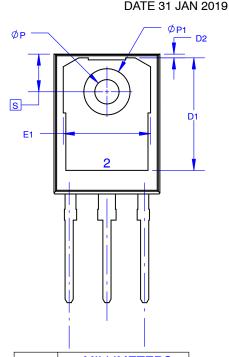
A = Assembly Location

Y = Year

WW = Work Week

ZZ = Assembly Lot Code

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.



DIM	MILLIMETERS				
DIIVI	MIN	NOM	MAX		
Α	4.58	4.70	4.82		
A 1	2.20	2.40	2.60		
A2	1.40	1.50	1.60		
b	1.17	1.26	1.35		
b2	1.53	1.65	1.77		
b4	2.42	2.54	2.66		
С	0.51	0.61	0.71		
D	20.32	20.57	20.82		
D1	13.08	~	~		
D2	0.51	0.93	1.35		
E	15.37	15.62	15.87		
E1	12.81	?	~		
E2	4.96	5.08	5.20		
е	~	5.56	~		
L	15.75	16.00	16.25		
L1	3.69	3.81	3.93		
ØΡ	3.51	3.58	3.65		
ØP1	6.60	6.80	7.00		
Q	5.34	5.46	5.58		
S	5.34	5.46	5.58		

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DESCRIPTION:	TO-247-3LD SHORT LEAD		PAGE 1 OF 1	

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